

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/601,661 | | Applicant(s)/Patent Under Reexamination SUGAHARA ET AL. | |
| | Examiner Richard K. Lee | | Art Unit 2832 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------|----------------|
| ✱ | A | US-4,392,030 | 07-1983 | Buss, Gary L. | 200/11R |
| ✱ | B | US-4,625,084 | 11-1986 | Fowler et al. | 200/11DA |
| ✱ | C | US-4,652,947 | 03-1987 | Oka et al. | 360/85 |
| ✱ | D | US-5,017,741 | 05-1991 | Brown et al. | 174/260 |
| ✱ | E | US-5,438,172 | 08-1995 | Fowler et al. | 200/11R |
| ✱ | F | US-5,794,766 | 08-1998 | Morita et al. | 200/569 |
| ✱ | G | US-6,340,801 | 01-2002 | Fukuda et al. | 200/18 |
| ✱ | H | US-6,388,211 | 05-2002 | Nomura et al. | 200/11DA |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.